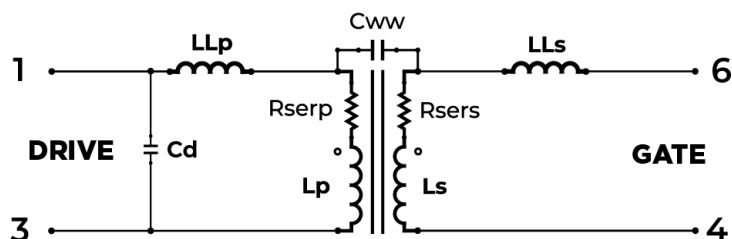


TEST CONDITIONS

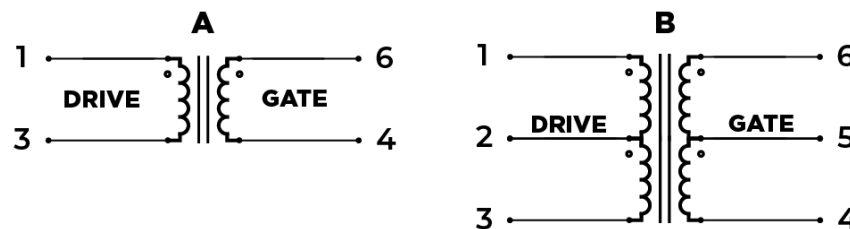
Inductance (L): 100 kHz, 0.1 V_{RMS}, Series
Leakage Inductance (LL): 100 kHz, 0.1 V_{RMS}, Series
Interwinding Capacitance (C_{ww}): 100 kHz, 0.1 V_{RMS}
Series Resistance (R_{ser}): Measured at 25 °C
Cd: Measured by HP4194A equivalent A

EQUIPMENTS: 4194A, 4285A, 4284A, HOIKI 3541

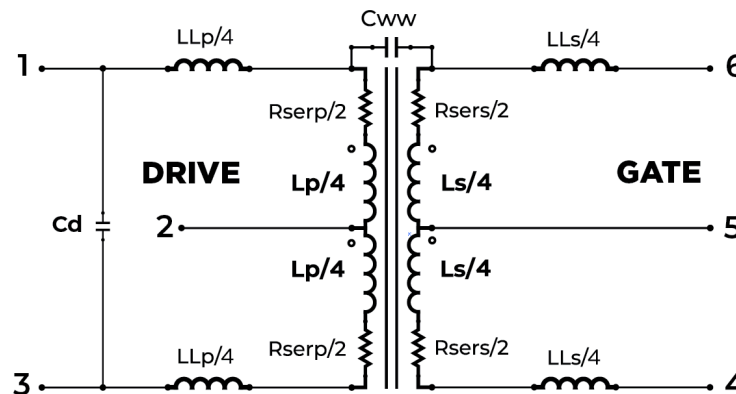
EQUIVALENT CIRCUIT (A: Non-Center-Tapped)



SCHEMATIC SYMBOL



EQUIVALENT CIRCUIT (B: Center-Tapped)



Part Number	Lp (1-3)	Ls (6-4)	Rserp (1-3)	Rser (6-4)	Cd	Cww (6,4) - (1,3)	SRF (1-3)	LLp (1-3) Shorted (6-4)	LLs (6-4) Shorted (1-3)	Turn Ratio	Schematic
	<i>uH, Typ.</i>	<i>uH, Typ.</i>	<i>mΩ, Typ.</i>	<i>mΩ, Typ.</i>	<i>pF, Typ.</i>	<i>pF, Typ.</i>	<i>MHz, Typ.</i>	<i>uH, Typ.</i>	<i>uH, Typ.</i>	<i>1-3:6-4</i>	<i>A/B</i>
GT07-110-013	169.67	169.67	240.7	197.7	3.42	3.00	7.63	0.13	0.13	1:1	A
GT07-111-027	567.67	686.88	493.3	366.7	3.64	4.60	4.31	0.34	0.41	1:1.1	B
GT07-120-045	285.33	1884.58	363.3	546.7	20.08	4.67	2.69	0.18	1.19	1:2.57	B